

Notice of References Cited

Application/Control No. 10/056,394	Applicant(s)/Patent Under Reexamination CHUAN ET AL.	
Examiner Jean F. Duverne	Art Unit 2839	Page 1 of 1

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	B	US-2002/0167793 A1	11-2002	Branch et al.	361/686
	C	US-6,371,787 B1	04-2002	Branch et al.	439/352
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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